


<b>Search Notes</b>  	<b>Application/Control No.</b>  10551275	<b>Applicant(s)/Patent Under Reexamination</b>  TAKAHASHI, TETSUYA
	<b>Examiner</b>  Goff, John L	<b>Art Unit</b>  1733

SEARCHED			
Class	Subclass	Date	Examiner
156	212,213,214,221,245,308.4,309.6	8/7/07	JLG
29	730,623.2	8/7/07	JLG
429	178,180,181	8/7/07	JLG

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB) - See Search History Printout	8/7/07	JLG
Palm Inventor Search	8/7/07	JLG

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner